

Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

1. (currently amended) A method for isolating failed routing resources on a programmable integrated circuit, the method comprising:
receiving a plurality of failed test patterns, wherein a test pattern includes program bits that define how routing resources on the programmable integrated circuit are connected to form a test path, wherein a test pattern is designated as failing when a result from a test path is erroneous, wherein the result of the failed test path is created by applying one or more test values to the failed test path;
identifying a subset of the routing resources that occur most frequently in the failed test paths; and
generating new test patterns including program bits that define new test paths for testing the subset of the routing resources that occurred most frequently in the failed test paths, wherein at least one new test path includes:
every routing resource of the subset under test; and
at least one other resource not in the subset ~~that was not previously coupled with that routing resource in one of the failed test paths.~~
2. (original) The method according to claim 1 further comprising:
testing the new test patterns using a test system to isolate routing resources among the subset of the routing resources that caused the erroneous results in the failed test patterns.
3. (original) The method according to claim 1 wherein generating the new test patterns for the subset of the routing resources further comprises:

generating new test patterns for new test paths that route through every combination of fan-in resources and fan-out resources that are programmably connectable to each of the subset of the routing resources.

4. (original) The method according to claim 1 wherein generating the new test patterns for the subset of the routing resources further comprises:

generating new test patterns for test paths that route through clock and clear signal routing resources.

5. (original) The method according to claim 1 wherein each of the failed test paths and the new test paths connect a control point to an observation point on the programmable integrated circuit.

6. (original) The method according to claim 1 wherein the routing resources have more than 1000 times as many routing resources as the subset of routing resources.

7. (original) The method according to claim 5 further comprising:
receiving a test log file that indicates the observation points for the failed test paths.

8. (original) The method according to claim 1 wherein identifying the subset of the routing resources that occur most frequently in the failed test paths further comprises:

extracting the routing resources that are connected along each of the failed test paths using a connectivity graph.

9. (currently amended) A computer program product encoded on a computer readable medium for isolating failed routing resources on a programmable integrated circuit, the computer readable medium comprising:

code for receiving a plurality of failed test patterns generating erroneous results when test values are applied to a set of failed test paths, wherein a test pattern includes program bits that define how routing resources on the programmable integrated circuit are connected to form a test path;

code for identifying a subset of the routing resources that occur most frequently in the failed test paths; and

code for generating new test patterns including program bits that define new test paths for testing the subset of the routing resources that occurred most frequently in the failed test paths, wherein at least one new test path includes:

every routing resource of the subset under test; and

at least one other resource ~~that was not previously coupled with that routing resource in one of the failed test paths.~~

10. (original) The computer program product of claim 9 wherein the code for receiving and identifying further comprises:

code for receiving a test log file that indicates observation points for the failed test paths.

11. (original) The computer program product of claim 9 wherein the code for generating further comprises:

code for generating new test patterns for test paths that route through clock and clear signal routing resources.

12. (original) The computer program product of claim 9 further comprising:

code for testing the new test patterns to isolate routing resources among the subset that caused the erroneous results in the failed test patterns.

13. (original) The computer program product of claim 9 wherein the code for generating further comprises:

code for generating new test patterns that route through every combination of fan-in resources and fan-out resources that are programmably connectable to each of the subset of the routing resources.

14. (original) The computer program product of claim 9 wherein the routing resources have more than 10,000 times as many routing resources as the subset of the routing resources.

15. (currently amended) A computer system for isolating failed routing resources on a programmable integrated circuit, the computer system comprising:
a statistical failure isolation (SFI) tool that identifies a subset of routing resources that occur most frequently in failed test paths, wherein the SFI tool receives a plurality of failed test patterns that generated erroneous results when test values are applied to a set of failed test paths, wherein a test pattern includes program bits that define how routing resources on the programmable integrated circuit are connected to form a test path; and
an adaptive failure isolation (AFI) tool that generates new test patterns including program bits that define new test paths for testing the subset of the routing resources that occurred most frequently in the failed test paths, wherein at least one new test path includes:
every routing resource of the subset under test; and
at least one other resource ~~that was not previously coupled with that routing resource in one of the failed test paths.~~

16. (original) The computer system according to claim 15 wherein the SFI tool also receives a test log file that indicates observation points for the failed test paths.

17. (original) The computer system according to claim 15 further comprising:
a test system that tests the new test patterns to isolate routing resources among the subset that caused the erroneous results in the failed test patterns.

18. (original) The computer system according to claim 15 wherein:
the AFI tool generates new test patterns for new test paths that route through
every combination of fan-in resources and fan-out resources that are programmably connectable
to each of the subset of the routing resources.

19. (original) The computer system according to claim 15 wherein the
routing resources have more than 1000 times as many routing resources as the subset of routing
resources.

20. (original) The computer system according to claim 15 wherein the
SFI tool extracts the routing resources that are connected along each of the failed test paths using
a connectivity graph.

21. (previously presented) The method of claim 1, wherein each of the
new test paths is used to determine whether the resources of the subset have actually failed.

22. (previously presented) The method of claim 1, wherein the
erroneous result of a failed test path is an output value of the failed test path that does not equal
an expected value.

23. (previously presented) The method of claim 2, wherein the testing a
new test pattern tests a clock control point and comprises:

scanning in a first value to a failed resource;
scanning in a second value to a data control point coupled with the failed
resource;
scanning out the value stored in the failed resource and comparing that value to
the first value;
transmitting a clock signal from the clock control point to the failed resource; and
scanning out the value stored in the failed resource and comparing that value to
the second value.

24. (previously presented) The method of claim 2, wherein the testing a new test pattern tests a clear control point and comprises:

- scanning in a first value into a failed resource;
- scanning out the value stored in the failed resource and comparing that value to the first value;
- transmitting a clear signal from the clear control point to the failed resource; and
- scanning out the value stored in the failed resource and comparing that value to a clear value.